

Integrated Device Technology, Inc. 6024 Silver Creek Valley Road, San Jose, CA - 95138

PRODUCT/PROCESS CHANGE NOTICE (PCN)							
PCN #: I-0707-01	MEANS OF DIST	INGUISHING C	HANGED DEVICES:				
89H	PES24N3A, 89HPES12N3A, 89HPES24T6, PES32T8, 89HPES16T4, 89HPES16T7 & PES8T5 - BGA Packages	■ Product Mark□ Back Mark□ Date Code	Change in Order	ing Part Number			
Date Effective: July 30, 2007		□ Other					
Contact: Bimla P	aul						
Title: Quality Assurance Manager		Attachment::	Yes	☐ No			
Phone #: (408) 574-6419							
Fax #: (408) 28		Samples:	N/A				
	Paul@idt.com						
	PURPOSE OF CHANGE:						
☐ Die Technology		This notification is to advise our customers that IDT has qualified a new die revision to					
☐ Wafer Fabrication Pr		ldress the device errata. The details are as follow:					
☐ Assembly Process		Device die revision from Mark Revision "ZC" to Mark Revision "ZG" for					
☐ Equipment 89HPES24N3A, 89HPES12N3							
☐ Material Revision "ZH" for 89HPES3			89HPES16T7 & 8	9HPES8T5 to			
☐ Testing enhance the device performan ☐ Manufacturing Site		ce.					
■ Data Sheet			_				
Other	There will be a change in orde	ring part number. Ple	ease see attachmer	it for details.			
	IFICATION SUMMARY: See attached da	nta. There is no chan	ge to the die techn	ology/process.			
IDT records indicate that to grant approval or req it will be assumed that t	WLEDGMENT OF RECEIPT: at you require written notification of this char uest additional information. If IDT does not a his change is acceptable. o ship either version manufactured after the p as been depleted.	eceive acknowledge	ment within 30 da	ys of this notice			
Customer:		Approval for sh	ipments prior	to effective date.			
Name/Date: E-M		Mail Address:					
Title: Phor		one# /Fax# :					
CUSTOMER COMMENTS:							
IDT ACKNOWLEDGE	MENT OF RECEIPT:						
RECD. BY:		DATE:					



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PCN Type: Die revision

Data Sheet Change Yes

Detail of ChangeThis notification is to advise our customers that IDT has qualified a new die revision to address the

device errata. The details are as follow:

Device die revision from Mark Revision "ZC" to Mark Revision "ZG" for 89HPES24N3A, 89HPES12N3A & 89HPES24T6 and from Mark Revision "ZD" to Mark Revision "ZH" for 89HPES32T8, 89HPES16T4, 89HPES16T7 & 89HPES8T5 to enhance the device performance.

There will be a change in ordering part number. Please see Table 1 for details.

The new die revision will address the known errata items as follow:

For 89HPES24N3A, 89HPES12N3A & 89HPES24T6 Mark Revision "ZC" Errata & 89HPES32T8, 89HPES16T4, 89HPES16T7 & 89HPES8T5 Mark Revision "ZD" Errata

- 1. Eliminate errata item 1 : WRR malfunction on repeated loading of PA table.
- 2. Eliminate errata item 2 : Device may corrupt a specific JTAG pattern.
- 3. Eliminate errata item 3: Missing electrical idle ordered set results in perpetual L1 state.
- 4. Eliminate errata item 4 : ACK latency is miscalculated on all ports.
- 5. Eliminate errata item 5 : Device unable to transmit DLLPs in some cases.
- 6. Eliminate errata item 6: Writing to the PCIESCTL register resets the PCIESCAP register to default value.
- 7. Eliminate errata item 7 : I/O Expander hot-plug outputs incorrect in certain specific instances.
- 8. Eliminate errata item 8 : CC bit in PCIESSTS register set by an EEPROM based initialization write to PCIESCTL register.
- 9. Modified revision ID

Table 1

ZC to ZG Transition Parts		ZD to ZH Transition Parts		
Old Part #	New Part#	Old Part #	New Part#	
89HPES12N3AZCBC	89HPES12N3AZGBC	89HPES8T5ZDBC	89HPES8T5ZHBC	
89HPES12N3AZCBCG	89HPES12N3AZGBCG	89HPES8T5ZDBCG	89HPES8T5ZHBCG	
89HPES24N3AZCBX	89HPES24N3AZGBX	89HPES16T4ZDBC	89HPES16T4ZHBC	
89HPES24N3AZCBXG	89HPES24N3AZGBXG	89HPES16T4ZDBCG	89HPES16T4ZHBCG	
89HPES24T6ZCBX	89HPES24T6ZGBX	89HPES16T7ZDBX	89HPES16T7ZHBX	
89HPES24T6ZCBXG	89HPES24T6ZGBXG	89HPES16T7ZDBXG	89HPES16T7ZHBXG	
		89HPES32T8ZDBX	89HPES32T8ZHBX	
		89HPES32T8ZDBXG	89HPES32T8ZHBXG	

Note: For T&R, "T" suffix is added to the part#



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Qualification Data

Test Vehicle: IDT89HPES24N3A

Qualification Test Plan and Results:

Test Description		Test Results (SS/# Of Fails
Dynamic High Temp Operating Life Test	77/0	77/0
* Temperature Cycling (-65 °C to 150 °C, 500 cycle)	45/0	45/0
* Highly Accelerated Stress Test (HAST) (130 °C,85% RH, 100 Hrs)	45/0	45/0
ESD HBM	3/0	3/0
ESD CDM	3/0	3/0

Notes: * Test requires Moisture Pre-Conditioning sequence.